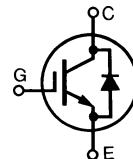
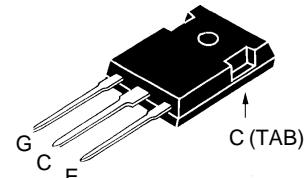


# Low $V_{CE(sat)}$ IGBT with Diode High Speed IGBT with Diode Combi Pack

	$V_{CES}$	$I_{C25}$	$V_{CE(sat)}$
IXGH 12N100U1	1000 V	24 A	3.5 V
IXGH 12N100AU1	1000 V	24 A	4.0 V



Symbol	Test Conditions	Maximum Ratings	
$V_{CES}$	$T_J = 25^\circ\text{C}$ to $150^\circ\text{C}$	1000	V
$V_{CGR}$	$T_J = 25^\circ\text{C}$ to $150^\circ\text{C}$ ; $R_{GE} = 1 \text{ M}\Omega$	1000	V
$V_{GES}$	Continuous	$\pm 20$	V
$V_{GEM}$	Transient	$\pm 30$	V
$I_{C25}$	$T_c = 25^\circ\text{C}$	24	A
$I_{C90}$	$T_c = 90^\circ\text{C}$	12	A
$I_{CM}$	$T_c = 25^\circ\text{C}, 1 \text{ ms}$	48	A
<b>SSOA</b> <b>(RBSOA)</b>	$V_{GE} = 15 \text{ V}$ , $T_{VJ} = 125^\circ\text{C}$ , $R_G = 150 \Omega$ Clamped inductive load, $L = 300 \mu\text{H}$	$I_{CM} = 24$ @ $0.8 V_{CES}$	A
$P_c$	$T_c = 25^\circ\text{C}$	100	W
$T_J$		-55 ... +150	$^\circ\text{C}$
$T_{JM}$		150	$^\circ\text{C}$
$T_{stg}$		-55 ... +150	$^\circ\text{C}$
$M_d$	Mounting torque with screw M3	1.13/10	Nm/lb.in.
<b>Weight</b>		6	g
Maximum lead temperature for soldering 1.6 mm (0.062 in.) from case for 10 s		300	$^\circ\text{C}$

**TO-247AD**


G = Gate      C = Collector  
E = Emitter      TAB = Collector

**Features**

- International standard packages JEDEC TO-247
- IGBT with antiparallel FRED in one package
- HDMOS™ process
- Low  $V_{CE(sat)}$ 
  - for minimum on-state conduction losses
- MOS Gate turn-on
  - drive simplicity
- Fast Recovery Expitaxial Diode (FRED)
  - soft recovery with low  $I_{RM}$

**Applications**

- DC choppers
- AC motor speed control
- DC servo and robot drives
- Uninterruptible power supplies (UPS)
- Switch-mode and resonant-mode power supplies

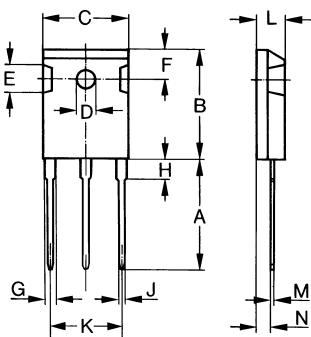
**Advantages**

- Easy to mount with one screw
- Reduces assembly time and cost
- Space savings (two devices in one package)

Symbol	Test Conditions	Characteristic Values		
	( $T_J = 25^\circ\text{C}$ , unless otherwise specified)	Min.	Typ.	Max.
$BV_{CES}$	$I_c = 3 \text{ mA}$ , $V_{GE} = 0 \text{ V}$ $BV_{CES}$ temperature coefficient	1000		V
			0.072	%/K
$V_{GE(th)}$	$I_c = 500 \mu\text{A}$ , $V_{GE} = V_{GE}$ $V_{GE(th)}$ temperature coefficient	2.5	5.5	V
			-0.192	%/K
$I_{CES}$	$V_{CE} = 0.8$ , $V_{CES}$ $V_{GE} = 0 \text{ V}$	$T_J = 25^\circ\text{C}$		$300 \mu\text{A}$
		$T_J = 125^\circ\text{C}$		5 mA
$I_{GES}$	$V_{CE} = 0 \text{ V}$ , $V_{GE} = \pm 20 \text{ V}$			$\pm 100 \text{ nA}$
$V_{CE(sat)}$	$I_c = I_{CE90}$ , $V_{GE} = 15$	12N100U1 12N100AU1		$3.5 \text{ V}$ $4.0 \text{ V}$

Symbol	Test Conditions ( $T_J = 25^\circ\text{C}$ , unless otherwise specified)	Characteristic Values		
		Min.	Typ.	Max.
$g_{fs}$	$I_C = I_{C90}$ ; $V_{CE} = 10 \text{ V}$ , Pulse test, $t \leq 300 \mu\text{s}$ , duty cycle $\leq 2\%$	6	10	S
$C_{ies}$	$V_{CE} = 25 \text{ V}$ , $V_{GE} = 0 \text{ V}$ , $f = 1\text{MHz}$	750	pF	
$C_{oes}$		120	pF	
$C_{res}$		30	pF	
$Q_g$	$I_C = I_{C90}$ , $V_{GE} = 15 \text{ V}$ , $V_{CE} = 0.5 V_{CES}$	65	90	nC
$Q_{ge}$		8	20	nC
$Q_{gc}$		24	45	nC
$t_{d(on)}$	<b>Inductive load, <math>T_J = 25^\circ\text{C}</math></b> $I_C = I_{C90}$ , $V_{GE} = 15 \text{ V}$ , $L = 300 \mu\text{H}$ $V_{CE} = 800 \text{ V}$ , $R_G = R_{off} = 120 \Omega$ Remarks: Switching times may increase for $V_{CE}$ (Clamp) $> 0.8 V_{CES}$ , higher $T_J$ or increased $R_G$	100	ns	
$t_{ri}$		200	ns	
$t_{d(off)}$		850	1000	ns
$t_{fi}$		800	1000	ns
$E_{off}$		500	700	ns
		12N100U1	12N100AU1	12N100U1
$t_{d(on)}$	<b>Inductive load, <math>T_J = 125^\circ\text{C}</math></b> $I_C = I_{C90}$ , $V_{GE} = 15 \text{ V}$ , $L = 300 \mu\text{H}$ $V_{CE} = 800 \text{ V}$ , $R_G = R_{off} = 120 \Omega$ Remarks: Switching times may increase for $V_{CE}$ (Clamp) $> 0.8 V_{CES}$ , higher $T_J$ or increased $R_G$	100	ns	
$t_{ri}$		200	ns	
$E_{(on)}$		1.1	mJ	
$t_{d(off)}$		900	ns	
$t_{fi}$		12N100U1	12N100AU1	12N100U1
$E_{off}$		1250	ns	12N100AU1
$R_{thJC}$		950	ns	3.5
$R_{thCK}$			2.2	mJ
				K/W
			0.25	K/W

## TO-247 AD (IXGH) Outline



Dim.	Millimeter Min.	Millimeter Max.	Inches Min.	Inches Max.
A	19.81	20.32	0.780	0.800
B	20.80	21.46	0.819	0.845
C	15.75	16.26	0.610	0.640
D	3.55	3.65	0.140	0.144
E	4.32	5.49	0.170	0.216
F	5.4	6.2	0.212	0.244
G	1.65	2.13	0.065	0.084
H	-	4.5	-	0.177
J	1.0	1.4	0.040	0.055
K	10.8	11.0	0.426	0.433
L	4.7	5.3	0.185	0.209
M	0.4	0.8	0.016	0.031
N	1.5	2.49	0.087	0.102

Symbol	Test Conditions ( $T_J = 25^\circ\text{C}$ , unless otherwise specified)	Characteristic Values		
		Min.	Typ.	Max.
$V_F$	$I_F = 8\text{A}$ , $V_{GE} = 0 \text{ V}$ , Pulse test, $t \leq 300 \mu\text{s}$ , duty cycle $d \leq 2\%$		2.75	V
$I_{RM}$	$I_F = I_{C90}$ , $V_{GE} = 0 \text{ V}$ , $-di_F/dt = 100 \text{ A}/\mu\text{s}$	6.5		A
$t_{rr}$	$V_R = 540 \text{ V}$ $I_F = 1 \text{ A}$ , $-di/dt = 50 \text{ A}/\mu\text{s}$ , $V_R = 30 \text{ V}$	$T_J = 125^\circ\text{C}$ $T_J = 25^\circ\text{C}$	120 50	ns ns
$R_{thJC}$			60	K/W
			2.5	

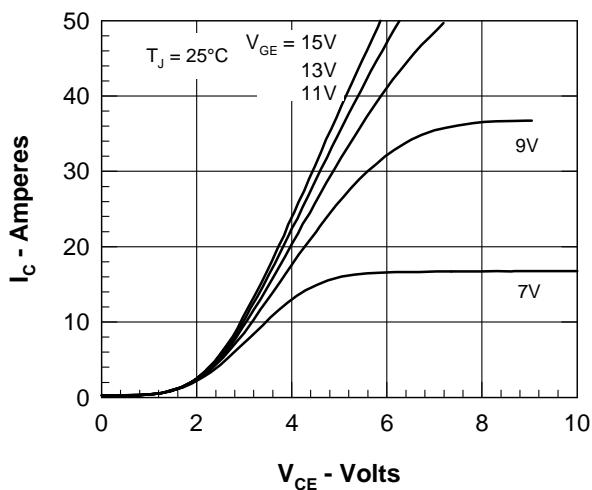


Figure 1. Saturation Voltage Characteristics

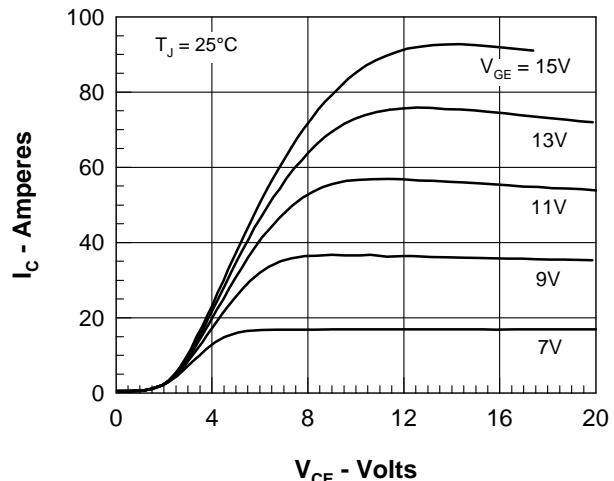


Figure 2. Extended Output Characteristics

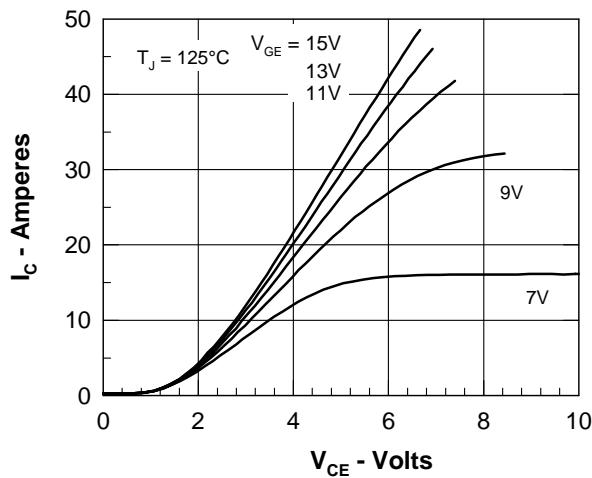


Figure 3. Saturation Voltage Characteristics

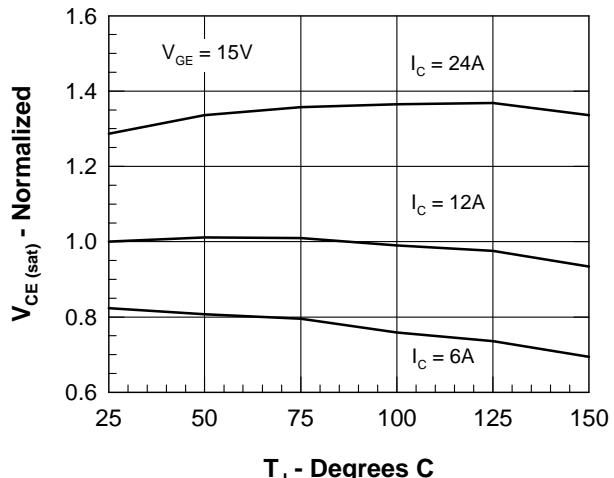
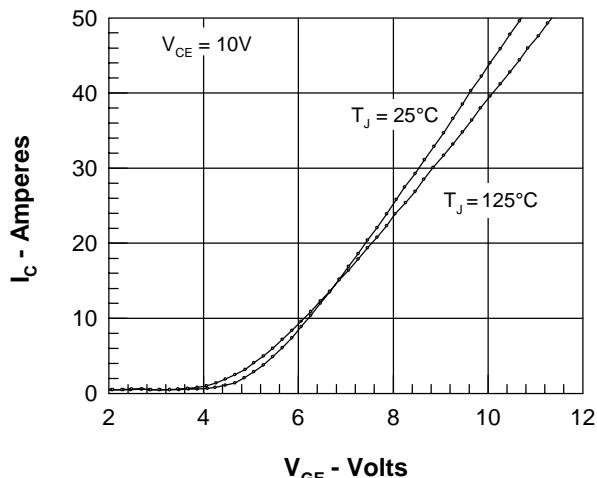
Figure 4. Temperature Dependence of  $V_{CE(sat)}$ 

Figure 5. Admittance Curves

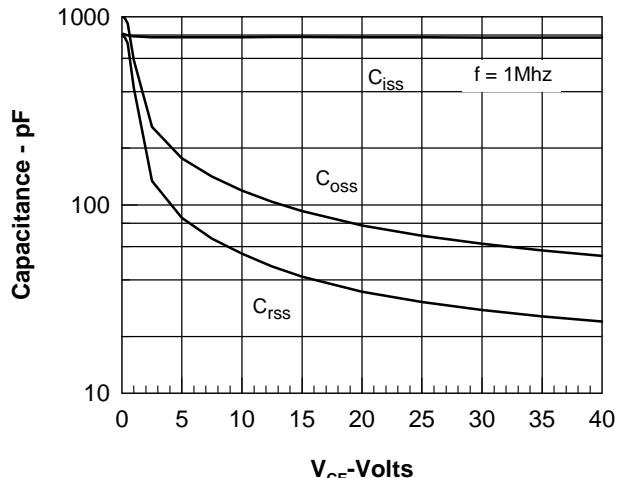


Figure 6. Capacitance Curves

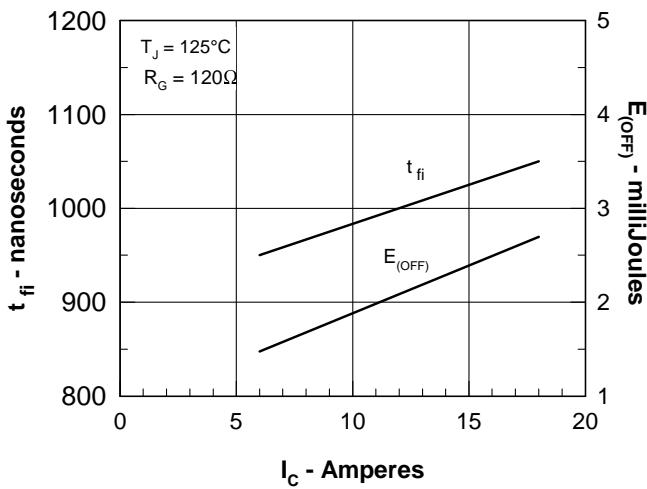
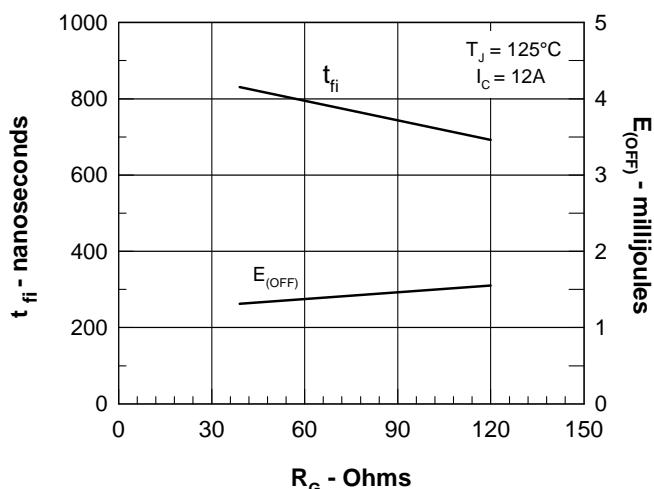
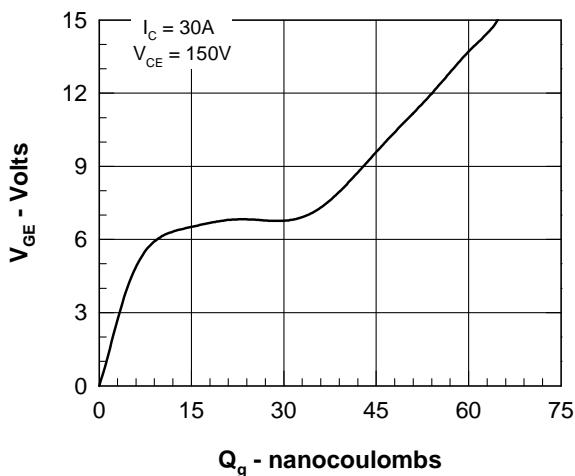
Figure 7. Dependence of  $t_{fi}$  and  $E_{(OFF)}$  on  $I_C$ .Figure 8. Dependence of  $t_{fi}$  and  $E_{(OFF)}$  on  $R_G$ .

Figure 9. Gate Charge

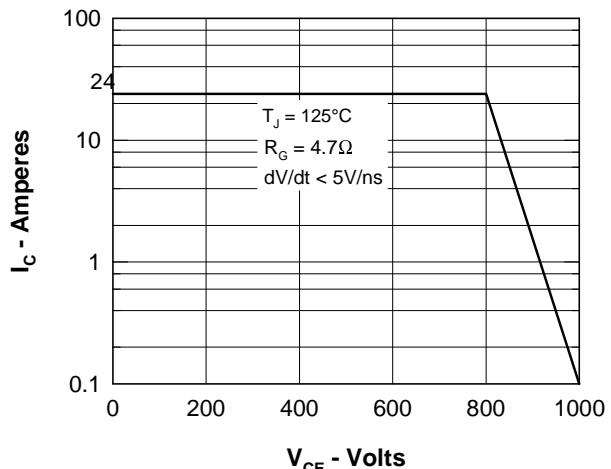


Figure 10. Turn-off Safe Operating Area

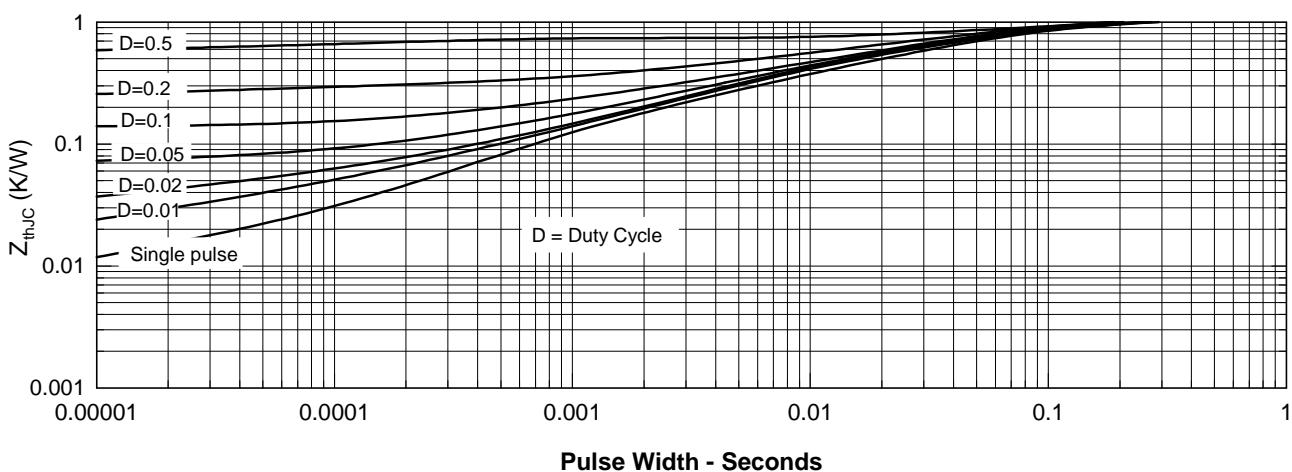


Figure 11. Transient Thermal Resistance

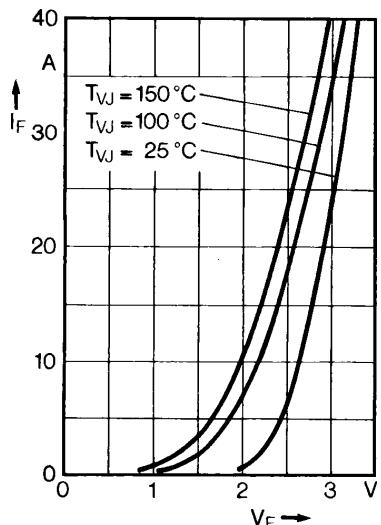


Fig. 12. Forward current versus voltage drop.

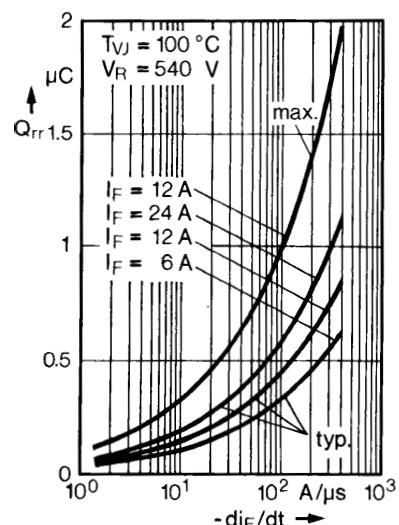


Fig. 13. Recovery charge versus  $-di_F/dt$ .

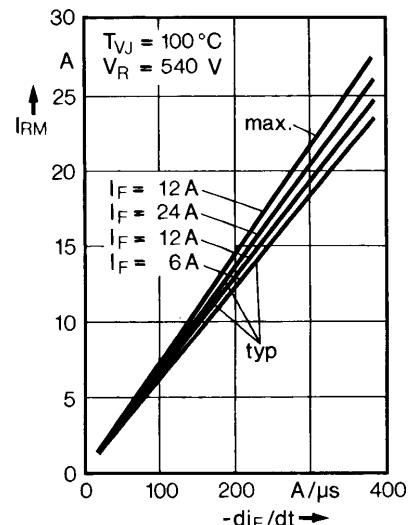


Fig. 14. Peak reverse current versus  $-di_F/dt$ .

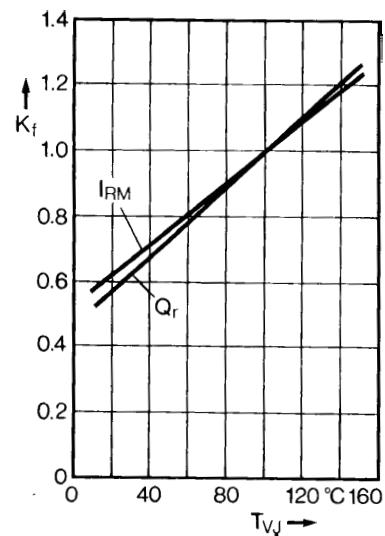


Fig. 15. Dynamic parameters versus junction temperature.

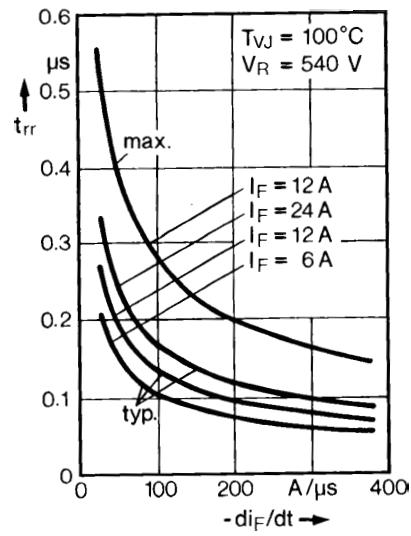


Fig. 16. Reverse recovery time . versus  $-di_F/dt$

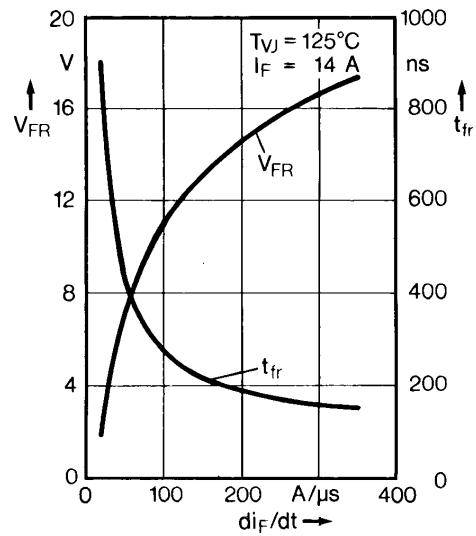


Fig. 17. Forward voltage recovery and time versus  $-di_F/dt$ .

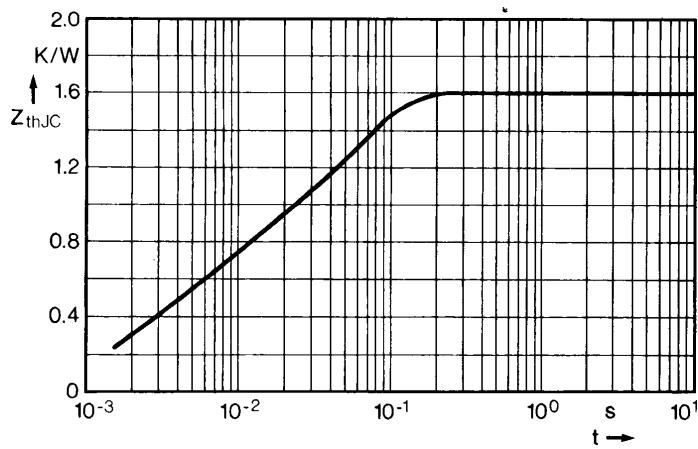


Fig. 18. Transient thermal impedance junction to case.